





# Loss characterisation of magnetic materials for integration on silicon

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## **Background / introduction :**

In the design of magnetic components on silicon, factors relating to core loss contributions include:

- High switching frequencies, in the MHz range
- Eddy current and hysteresis effects
- Sensitivity of materials to processing conditions
- Difficulty in determining core loss contributions in device designs

This work describes methods for measuring the power loss density of electroplated magnetic alloys **prior** to their integration in silicon.

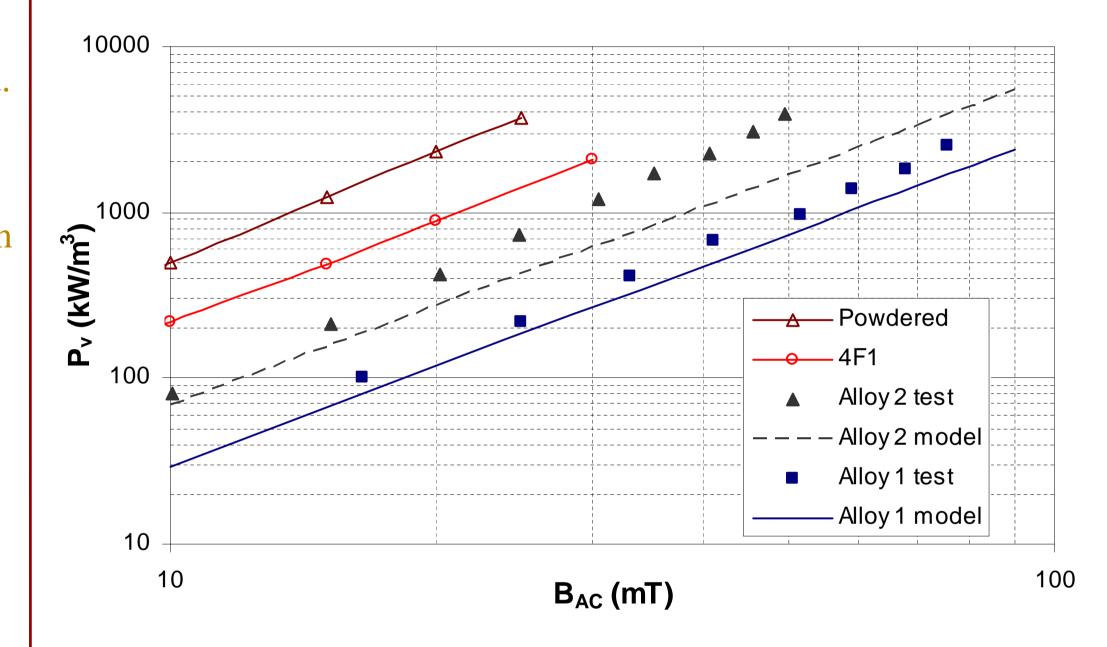
- most suitable materials for a given application may be identified
- impact of processing conditions may be determined
- relative contribution of core loss to total loss can be determined
- developments for improved efficiency may be more easily identified.

### **Practical measurement issues**

- Compensation for air-core flux is applied using measurements on an equivalent air-core structure
- Current probe delay is accounted for using measurements on an air-core sample
- Oscilloscope sampling rate limits the frequency range of measurements

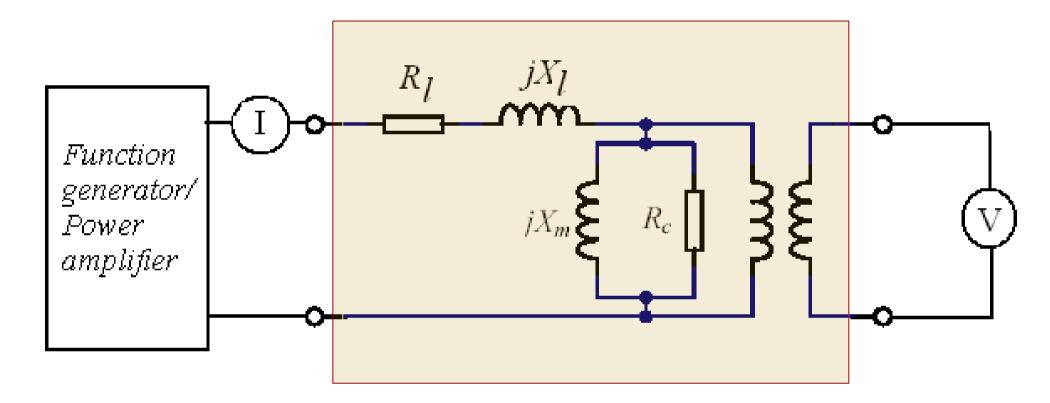
#### **Comparison of different metal alloy losses**

Results of power loss density for two different alloys are compared with ferrite and powdered metal materials at 3 MHz in Fig. 2. Sinusoidal excitation waveforms were applied in this case.



### **Power Loss Characterisation Technique**

Loss characteristics are measured using the transformer method with the equipment set-up shown in Fig. 1.



#### **Fig. 1 Loss characterisation equipment set-up**

The material sample should form be in the form of a closed core, uniformly wound with two windings having equal numbers of turns. A voltage source is applied to the primary winding and the open-circuit voltage, V, is measured on the secondary side.

Assuming the equivalent circuit model shown in Fig. 1 for the wound sample, total core loss is found as the power dissipated in the resistor

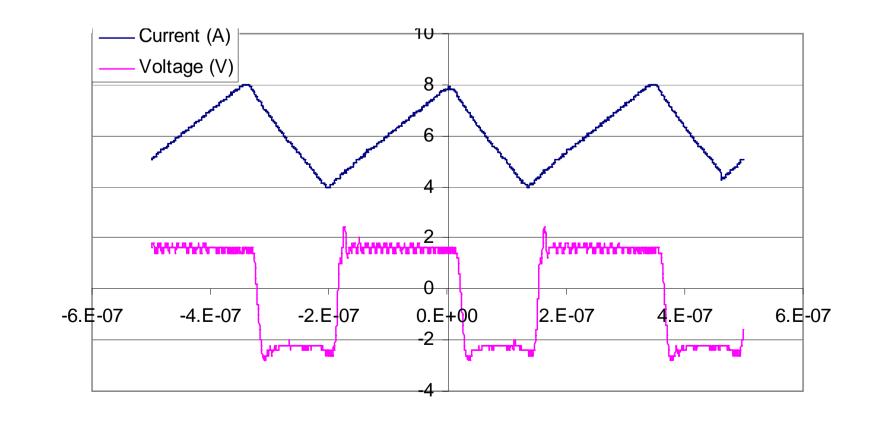
$$P = \frac{1}{T} \int_0^T v(t)i(t)dt$$

R<sub>c</sub>:

#### **Fig. 2** Comparison of material loss properties

- >Measurement procedure was verified through matching results with commercial material's data
- >Metal alloys provide superior performance to commercial materials in the MHz range
- ► Models for eddy-current and hysteresis losses show correct trends in loss characteristics

Work is ongoing to measure losses under non-sinusoidal excitation conditions such as in a VRM as shown in Fig. 3.



Losses are usually normalised to produce plots of power loss density, P<sub>v</sub>, versus magnetic flux density, B, where:

$$P_{v} = \frac{P}{v_{mat}}, \qquad B = \frac{1}{NA_{c}} \int_{0}^{t_{max}} v(t) dt$$

- $-v_{mat}$  is the volume of the material sample
- N is the number of turns on the secondary winding
- $-A_{c}$  is the cross sectional area of the material sample
- $-t_{max}$  is the time at which B is at its maximum value

Losses due to different operating voltage waveforms can be determined in this way.

#### **Fig. 3 DC/DC excitation waveforms**

Future work will develop loss models to improve the accuracy of loss predictions and to account for non-sinusoidal operating waveforms.

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